

<b>Notice of References Cited</b>	Application/Control No. 10/711,605	Applicant(s)/Patent Under Reexamination JOHNSTON, DAVID W.	
	Examiner Tu T. Nguyen	Art Unit 2877	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0148876	07-2005	Endoh et al.	600/454
*	B	US-2003/0227622	12-2003	Priestley, Richard S.	356/365
*	C	US-2005/0207943	09-2005	Puzey, Kenneth A.	422/082.05
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2004/021884	03-2004	JAPAN	ENDOH et al	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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